How do we interrogate the electrons without roughing them up?

Andrew Das Arulsamy and Marco Fronzi

School of Physics, The University of Sydney, Sydney, New South W ales 2006, Australia

Electrons are indistinguishable, but the energy of each electron is dierent in dierent materials and if we can exploit this energy, then we can systematically study the changes of electronic properties in non free-electron metals.

One of the fundam ental requirem ents from the electronic characterizations of m aterials is to understand what parameters e ectively control the ow of electrons. But we do not have the authority to dem and nor persuade the N ature to reveal its secret param eters. Adding to that, all electrons are the same, indistinguishable, we cannot distinguish one from another, be it in a metal or a wood. However, the energy that each or a group of electrons possess is dierent in dierent materials due to di erent types of atom s in a given material. This is also true for electrons in atom s due to di erent magnitudes of electron-nucleus Coulom b force. In view of this, what we are proposing here is a methodology that, instead of roughing-up the electrons with various experim ental techniques, we can interrogate their parent atom s to reveal inform ation about their electronic energies. In other words, the atom ic ionization energy or the atom ic energy-level di erence (see Figure 1) can be used to theoretically predict the system atic changes to the conductivity, carrier density, electron-phonon interaction, heat capacity and spin-orbit coupling strength, with respect to di erent dopant in a given non free-electron compound. Such predictions are not only in portant for experimentalists to evaluate their data and design new materials, but also theoretically signi cant so as to understand what param eters in uence the m otion of electrons in strongly correlated m atter. The above stated objective (of interrogating the constituent atom s) can be achieved with the methodology proposed in the Refs. $^{1)(5)}$  which starts with the many-body Hamiltonian,

$$\hat{H}' = (E_0)':$$
 (1)

 $\hat{H}$  is the m any-body H am iltonian, while ' is the m any-body wavefunction. The eigenvalue,  $E_0$  is the total energy, in which  $E_0$  is the total energy at tem perature (T) equals zero and is the atom ic energy-level di erence. The + sign of is for the electron (0 ! +1) while the sign is for the hole (1 ! 0). U sing this new ly de ned total energy, we can derive the ionization energy based Ferm i-D irac statistics (iFDS), as given below 1)

$$f_{e}(E_{0}; ) = \frac{1}{e^{[(E_{0}+ ) E_{F}^{(0)}]=k_{B}T} + 1};$$

$$f_h (E_0; ) = \frac{1}{e^{E_F^{(0)} (E_0)] = k_B T} + 1};$$
 (2)

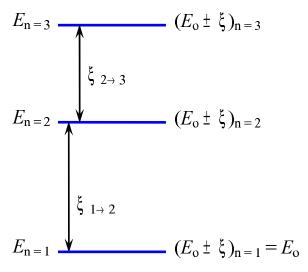


Fig. 1. Energy levels of hydrogen-like atom (not to scale).  $E_{n=1;2;3}$  is the standard energy level notation while,  $(E_0)_{n=1;2;3}$  is the new notation introduced from Eq. (1).

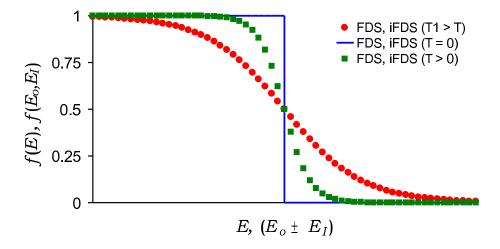


Fig. 2. Standard Ferm iD irac (FDS) and ionization energy based Ferm i-D irac (iFDS) distributions for tem peratures, T = 0, T > 0 and T1 > T.

where  $k_B$  is the Boltzm ann constant and E  $_F^{(0)}$  is the Ferm i level at tem perature equals zero. Figure 2 shows that the standard FDS and iFDS are theoretically exact, with non-trivial transform ation between them. The explicit content of this operator, H , namely, the kinetic and potential energy operators need not be known explicitly since is unique for each atom, which can be obtained from the experimental atom ic spectra. Using Eqn. (2), one can actually estimate the excitation probability

of electrons from di erent atom s in a given com pound. For exam ple, the total energy from Eqn. (1) carries the ngerprint of each constituent atom in a compound and it refers to the di erence in the energy levels of each atom rather than the absolute values of each energy level in each atom . Hence, the kinetic energy of each electron from each atom will be captured by the total energy and preserves the atom ic level electronic- ngerprint in the compound. The application of this theory is well established in strongly correlated matter namely, high-T<sub>c</sub> superconductors (cuprates), ferrom agnets (m anganites), diluted m agnetic sem iconductors and ferroelectrics (titanates). 1)(3) Physically, im plies the energy needed to overcom e the many-body potential energy that exists in a particular system. That is, is the energy needed to excite a particular electron to a  $\$ nite distance,  $\$ r, not  $\$ r !  $\$ 1 . In solids, the  $\$ m agnitude of is exactly what we need to know that reasonably de nes the electronic properties. Hence,  $= E_{\rm I}^{\rm real} / E_{\rm I}$ , where  $E_{\rm I}$  is the ionization energy of a free atom or ion (with r! 1), and its average value can be obtained from  $^{1)}$ 

$$E_{I} = \frac{X^{z}}{\sum_{i}^{z} E_{Ii}} :$$
 (3)

The subscripts, i=1,2,...z, where z denotes the number of valence electrons that can be excited or contributes to the electronic properties of a solid. Recently, various experim ental techniques have been employed by M anyala et al.  $^{6)}$  to measure the electronic properties, such as electrical conductivity, magnetic susceptibility and special cheat of M n doped FeSi compound, and yet, it is not possible to pin-point directly the reasons why and how systematic increment of M n content (from x=0.01 to 0.025) increased the conductivity (below 5K) and special cheat of Fe $_{1-x}M$   $_{1-x}M$   $_{1-x}M$  anyala et al. have indirectly explained the conductivity increment with M n content as due to increment of temperature—independent mobile carriers. The increment of mobile carriers is assumed from the magnetic susceptibility () results, where (T) curve shifts upward with x ( / x).

U sing our ionization energy theory, we can actually explain how and why the M n content changed the conductivity and speci cheat of Fe $_{\rm l}$  xM n $_{\rm x}$ Si in the regime that satis es the under-screened K ondo e ect. Firstly, the carrier density (n) can be calculated from  $^{1)}$ 

$$n = \int_{0}^{Z_{1}} f_{e}(E_{0}; E_{I}) N_{e}(E_{0}) dE_{0} / \exp \frac{E_{I}}{k_{B}T};$$
 (4)

where  $k_B$  denotes the Boltzm ann constant whereas,  $N_e (E_0)$  is the density of states. The speci cheat formula is given by  $^{1)}$ 

$$C_{v} = \frac{2^{-2}k_{B}}{5} \frac{k_{B}T}{\sim c} e^{-\frac{3}{2}(-E_{F}^{0})} / \exp -\frac{3}{2} E_{I};$$
 (5)

where e is the electronic charge, =  $(12_0=e^2)a_B$ , ~ is Planck constant, c is the sound velocity, 0 and 0 denote perm ittivity of free space and Bohr radius,

respectively. Hence, all we need to know now is the relationship between E  $_{\rm I}$  and x . Since M n doped FeSi is equivalent to hole doping, hen we can sum ise that the average valence state of M n should be less than Fe. Thus, using E qn. (3) we obtained the respective averaged values for the ionization energies, E  $_{\rm I}$  (M n  $^{2+;3+}$  = 1113.1, 1824.8 kJm ol  $^{1}$ ) < E  $_{\rm I}$  (Fe $^{3+;4+}$  = 1760.5, 2642.9 kJm ol  $^{1}$ ). Prior to averaging, the ionization energies for the elements, M n and Fe were taken from Ref. Smaller E  $_{\rm I}$  implies weak electron-phonon coupling that gives rise to easier electron—ow and also large carrier density. However, this scenario is reversed if E  $_{\rm I}$  is large. Consequently, M n content (with smaller E  $_{\rm I}$ ) systematically decreases the E  $_{\rm I}$  of the compound and subsequently increases the carrier density. This in turn shifts the T-dependent conductivity (below 5K) and speci cheat curves upward with respect to M n doping in Fe $_{\rm I}$  xM nxSi, due to Eqn. (4) and Eqn. (5), respectively. In principle, we can use this theory to ne-tune the conductivity in the under-screened K ondo regime or the speci cheat of Fe $_{\rm I}$  xM nxSi with elements other than M n.

## A cknow ledgm ents

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